

Notice of References Cited		Application/Control No. 09/852,122	Applicant(s)/Patent Under Reexamination CZECH ET AL.	
		Examiner N. Drew Richards	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,015,993 A	01-2000	Voldman et al.	257/355
	B	US-6,344,385 B1	02-2002	Jun et al.	438/237
	C	US-6,060,752 A	05-2000	Williams, Richard K.	257/355
	D	US-6,524,893 B2	02-2003	Kawazoe et al.	438/133
	E	US-5,182,220 A	01-1993	Ker et al.	438/200
	F	US-5,959,332 A	09-1999	Ravanelli et al.	257/360
	G	US-5,808,342 A	09-1998	Chen et al.	257/357
	H	US-6,118,154 A	09-2000	Yamaguchi et al.	257/360
	I	US-6,215,138 B1	04-2001	Takao, Noriyuki	257/288
	J	US-6,229,180 B1	05-2001	Yoshida et al.	257/355
	K	US-6,274,908 B1	08-2001	Yamaguchi et al.	257/355
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.